Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/678,893	CHANG ET AL.	
Examiner	Art Unit	
Sheng-Jen Tsai	2186	

SEARCHED						
Class	Subclass	Date	Examiner			
711	103	9/15/2006	SJT			
714	701	9/15/2006	SJT			
,						

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
	•				
		-			
	Subclass	Subclass Date			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
-	DATE	EXMR		
East: "ECC" with "flash memory" "ECC" with "non-volatile" "ECC" with "2-bit" "ECC" with "1-bit"	9/15/2006	SJT		
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